

## ORIGINAL ARTICLE

Crystal structure and enhanced microwave dielectric properties of Ta<sup>5+</sup> substituted Li<sub>3</sub>Mg<sub>2</sub>NbO<sub>6</sub> ceramics

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## Abstract

Composition and structure play dominant roles in realizing the microwave dielectric properties that are necessary for the ever-increasing demands of the Internet of Things and related communication technologies. In the present study, the substitution of Ta<sup>5+</sup> in Li<sub>3</sub>Mg<sub>2</sub>Nb<sub>1-x</sub>Ta<sub>x</sub>O<sub>6</sub> ceramics and its effect on the structural characteristics and microwave dielectric performances is systematically studied. All the substituted compositions were determined to be pure phase orthorhombic Li<sub>3</sub>Mg<sub>2</sub>NbO<sub>6</sub> structure of space group *Fddd*. Furthermore, a NbO<sub>6</sub> octahedral distortion, Nb-O bond valence, packing fraction and polarizability were calculated to explore the structure-property-performance paradigm in the context of microwave dielectric performance. Scanning electron microscopy revealed homogeneous microstructures, with the introduction of Ta<sup>5+</sup> promoting grain growth. Raman spectra indicated that the variation of the band (blue shift and red shift) at 771 cm<sup>-1</sup> was highly correlated with the variation in unit cell volume. The polarizability significantly impacted  $\epsilon_r$  values. The  $Q \times f$  values were strongly influenced by the packing fraction and grain size. The changes in the NbO<sub>6</sub> octahedral distortion and Nb-O bond valence impacted the  $\tau_f$  values. The Li<sub>3</sub>Mg<sub>2</sub>Nb<sub>0.98</sub>Ta<sub>0.02</sub>O<sub>6</sub> composition displayed the most dramatic improvements in microwave dielectric properties:  $\epsilon_r = 15.58$ ,  $Q \times f = 113\,000$  GHz and  $\tau_f = -4.5$  ppm/°C, providing a potential candidate for next generation microwave and millimeter-wave applications.

## KEYWORDS

Li<sub>3</sub>Mg<sub>2</sub>Nb<sub>1-x</sub>Ta<sub>x</sub>O<sub>6</sub> ceramics, microwave properties, millimeter-wave properties, orthorhombic structure, structural characterization

## 1 | INTRODUCTION

In recent years, dielectric materials have been widely researched to address the demand for passive devices, such as filters, capacitors, dielectric resonators, and functional substrates.<sup>1-4</sup> In order to increase the propagation velocity and inhibit signal damping, dielectric materials should possess

high quality factor and permittivity.<sup>5-8</sup> For practical engineering applications, the temperature coefficient of resonance frequency must be close to zero to guarantee the stability of performance.<sup>9,10</sup> However, many types of dielectric ceramics do not possess these properties. Instead, materials with high dielectric loss or large temperature coefficients of resonance frequency are quite common. Therefore, how to improve the

dielectric properties remains a central tenant of materials research and design efforts for microwave engineering applications.<sup>11–15</sup> In order to obtain the desired dielectric materials, a theory relating structure and microwave dielectric properties has been proposed.<sup>12,16–19</sup>

Recently, ceramic materials containing lithium having a rock-salt structure possess unique potential for practical applications due to suitable microwave dielectric properties.<sup>20</sup> Bian et al have researched the dielectric performance of  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  ceramics and discussed the structural evolution using X-ray diffractometry, infrared reflectivity, and Raman spectroscopy.<sup>21</sup> In order to modify the microwave dielectric performance, Zuo et al employed the introduction of  $\text{Zn}^{2+}$  ions for  $\text{Mg}^{2+}$ , which greatly improved the  $Q \times f$  values for  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  ceramics.<sup>15</sup> Additionally, Zhang et al adopted the concomitant introduction of strategic ion substitution and glass additives to modify the microwave dielectric properties.<sup>22–26</sup> However, these measurements did not show any significant effect on  $\tau_f$  values. In order to obtain a desirable near-zero  $\tau_f$  value, some structural characteristics were calculated to establish the relationship between the structure and dielectric performance.<sup>27,28</sup> In a previous work, these authors determined the dielectric performance of  $\text{Ni}_{0.5}\text{Ti}_{0.5}\text{Nb}_{1-x}\text{Ta}_x\text{O}_4$  ceramics.<sup>29</sup> Notably, the ionic radii of  $\text{Ta}^{5+}$  (0.64 Å) and  $\text{Nb}^{5+}$  (0.64 Å) are identical and therefore solid solutions are readily formed for low level cation substitutions. Alternatively, tantalum-containing materials usually have different crystal structures as compared to niobium-containing materials, hence, even low level substitutions of  $\text{Ta}^{5+}$  cations may perturb the structure of the parent compound and its microwave dielectric performance.

According to previous studies,  $\tau_f$  values of  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  ceramics can be tuned to near-zero by employing limited substitutions.<sup>30,31</sup> In the present study, a near-zero  $\tau_f$  was obtained for the composition having  $x = 0.02$ . Additionally, the  $Q \times f$  values first increase, reaching a maximum for  $x = 0.03$ , and then decrease, which indicates that a higher  $\text{Ta}^{5+}$  substitution content of  $x > 0.04$  does not exhibit any significant contribution to improving  $Q \times f$  values. The melting temperature of  $\text{Ta}_2\text{O}_5$ , that is, 1800°C, is substantially higher than that of  $\text{Nb}_2\text{O}_5$  i.e., 1480°C, and therefore, the sintering temperatures of samples having high  $\text{Ta}^{5+}$  content are expected to be higher than that of  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  ceramics. The troublesome evaporation of lithium occurs in  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  ceramics above 900°C, which is detrimental to the microwave dielectric properties.<sup>19</sup> High-temperature sintered  $\text{Li}_3\text{Mg}_2(\text{Nb}_{1-x}\text{Ta}_x)\text{O}_6$  ceramics therefore will suffer from considerable evaporation of lithium, resulting in a porous microstructure with limited application value. Due to these reasons, a limited range of substitutions has been investigated. The impact of the substitution of  $\text{Ta}^{5+}$  ions on enhancing the microwave dielectric properties and relating these properties to crystal structure are discussed.

Structural characterization, including the measurement of octahedra distortion, Nb-O bond valence, polarizability and packing fraction were determined using Rietveld refinement.

## 2 | EXPERIMENTAL PROCEDURES

### 2.1 | Materials preparation

New, low-loss  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ceramics were fabricated using the solid-state reaction process. High-purity starting materials of  $\text{Li}_2\text{CO}_3$ ,  $\text{Nb}_2\text{O}_5$ ,  $\text{Ta}_2\text{O}_5$ , and  $\text{MgO}$  (phase purities >99%) were employed. The chemicals were weighed adhering to the nominal stoichiometric ratios of the  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  compounds. The raw materials were mixed and ball-milled for 4 h. The processed powders were calcined at 1025°C in an alumina crucible for 4 h to compare with results of a previous study.<sup>27</sup> According to Wu and Kim,<sup>19</sup> minor evaporation of lithium occurs upon sintering at temperatures at ~1000°C. As a precaution, after calcination the surfaces exposed to air were removed. The remaining calcined powders were milled for another 4 h and pressed into cylindrical disks (i.e., pellets). These pellets were then surrounded by free powder of the same composition to provide a Li-rich local atmosphere and prevent exposure to the reactive atmosphere. These powders and pellets were then sintered from 1050 to 1150 for 4 h.

### 2.2 | Characterization

The phase purity of samples was analyzed using X-ray  $\theta$ – $2\theta$  powder diffraction employing an X-ray diffractometer (Philips X'pert Pro MPD) at room temperature using Cu-K $\alpha$  radiation ( $\lambda = 0.1542$  nm). The  $2\theta$  angles were measured from 10° to 120° with a step size of 0.02°. Rietveld refinement of measured  $\theta$ – $2\theta$  data were employed using the EXPGUI software suite.<sup>32</sup> Raman spectroscopy (InVia, Renishaw) was used to investigate the variations in crystal structure of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  samples, where  $x = 0, 0.01, 0.02, 0.03$ , and 0.04. The microstructure and morphology were analyzed using scanning electron microscopy (SEM; JEOL, JSM-6490). SEM micrographs were measured to obtain robust statistical analyses of grain sizes, as shown in Figure S1. For each composition, the analyzed sample area consisted of approximately 100 grains and the grain size distributions were obtained using Image-Pro Plus. The bulk densities were measured using Archimedes method. The relative permittivity and  $Q \times f$  values were calculated using the Hakki-Coleman method utilizing a network analyzer (Agilent, N5230A) over a frequency range of 9–12 GHz. A silver-coated cylindrical resonance cavity using a sample diameter-to-height ratio of approximately 2, where samples were placed in the center of the cavity, was employed. The unloaded  $Q$ -factor was determined using Equation 1.

$$Q = \frac{Q_L}{1 - 10^{-IL_0/20}} \quad (1)$$

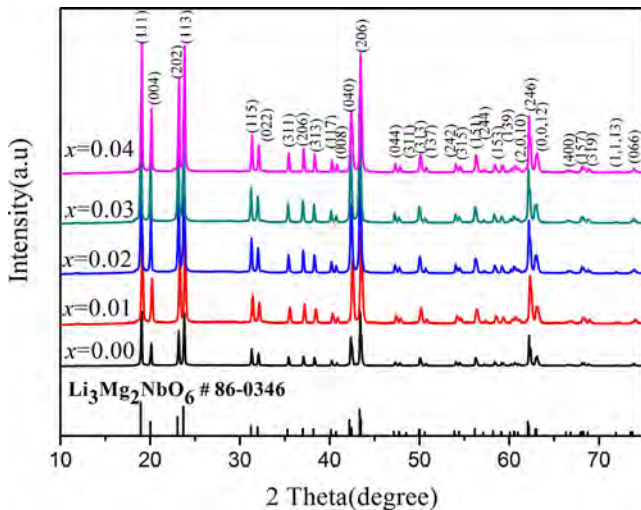
where  $Q_L$  is the loaded quality factor and can be calculated from the 3 dB full width of the resonance peak. Additionally,  $IL_0$  (dB) is the insertion loss, equal to the absolute value of  $S_{21}$  (dB). In order to prevent coupling the  $S_{21}$  parameter was adjusted to a value of less than  $-50$  dB. The total uncertainty of permittivity did not exceed 0.3% and the deviation of  $Q \times f$  value did not exceed 3%. The  $\tau_f$  values were determined according to the resonant frequency at temperatures of 25 and 85°C using Equation 2.

$$\tau_f = \frac{f_{85} - f_{25}}{f_{25} \times 60} \times 10^6 (\text{ppm}/^\circ\text{C}) \quad (2)$$

### 3 | RESULTS AND DISCUSSION

#### 3.1 | Phase identification and composition

Figure 1 shows the XRD patterns of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$  and  $0.04$ ) ceramics sintered at 1100°C. The standard diffraction patterns, extracted from PDF card



**FIGURE 1** XRD diffraction patterns of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0-0.04$ ) ceramics sintered at 1100°C

**TABLE 1** Lattice parameters, unit cell volume and the reliability factors of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$ , and  $0.04$ ) ceramics sintered at 1100°C

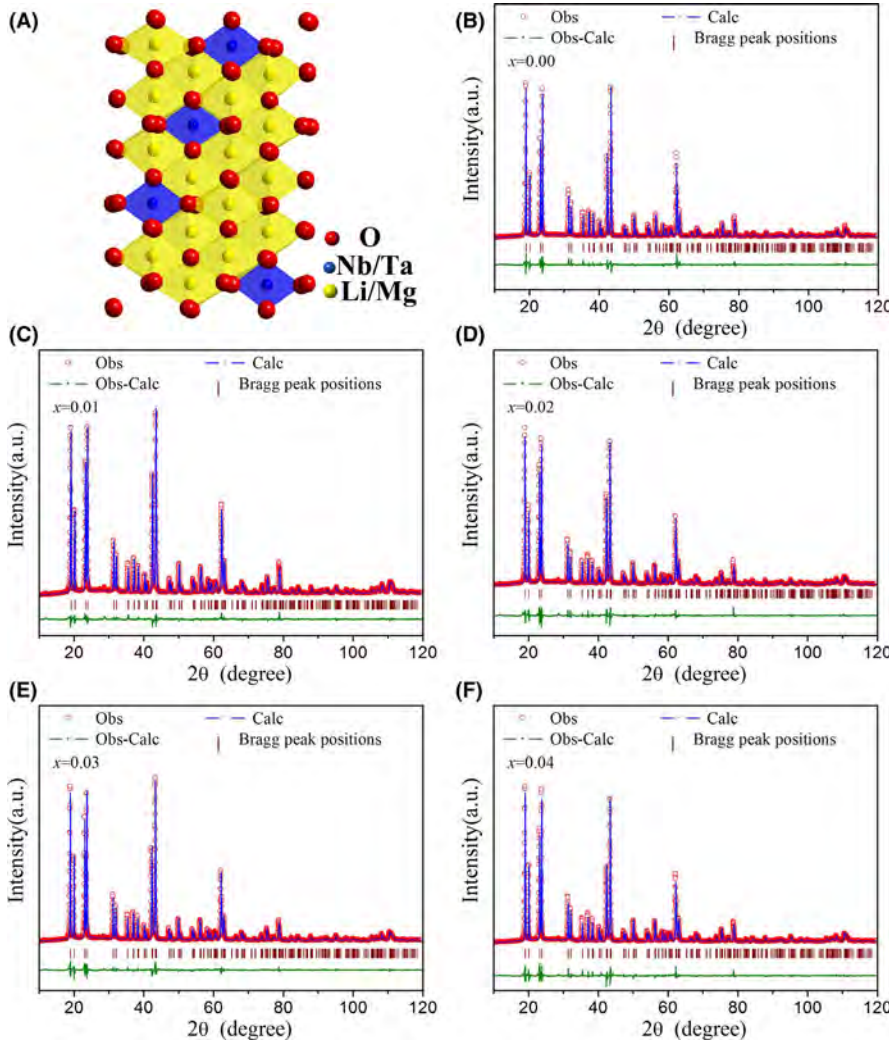
$x$	0.00	0.01	0.02	0.03	0.04
$a$ (Å)	5.9019	5.9003	5.8986	5.8969	5.8970
$b$ (Å)	8.5455	8.5446	8.54233	8.5417	8.5476
$c$ (Å)	17.7388	17.7346	17.73231	17.7251	17.7232
$V$ (Å <sup>3</sup> )	894.6371	894.110	893.998	893.7103	893.951
$R_p$ (%)	5.2	3.53	4.97	4.32	5.01
$R_{wp}$ (%)	7.0	4.82	6.95	5.87	6.91
$\chi^2$	2.2	2.6	3.7	2.9	4

86-0346, is provided and the crystallographic planes of all diffraction peaks for the experimental data are indexed. No secondary phases were detected above the detection limit of the instrument for all samples, indicating that the  $\text{Ta}^{5+}$  ions likely diffused into the lattice as substitute ions for the  $\text{Nb}^{5+}$  ions. This result is consistent with  $\text{Ta}^{5+}$  ions having the same ionic radius (0.64 Å) as that of  $\text{Nb}^{5+}$  ion (0.64 Å). According to Goldschmidt's rule, the difference in ionic radii ( $\Delta R$ ) for ionic substitution is given by Equation 3.<sup>33</sup>

$$\Delta R = \frac{R_{\text{Ta}} - R_{\text{Nb}}}{R_{\text{Nb}}} \quad (3)$$

Accordingly, if  $\Delta R$  is less than 15%, a solid solution is expected. Ringwood et al also investigated the substitution rules based upon electronegativity and found that the difference in electronegativity is about 0.1 in most of the cases involving substitution.<sup>34</sup> In the present work,  $\Delta R$  and the difference in electronegativity between  $\text{Ta}^{5+}$  ions and  $\text{Nb}^{5+}$  ion are 0 and 0.1, respectively. Additionally, unit cell parameters varied due to the possible evaporation of lithium and differences in electronegativity of  $\text{Ta}^{5+}$  and  $\text{Nb}^{5+}$  ions, as presented in Table 1.

Figure 2 shows a schematic of the  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  unit cell with orthorhombic structure and Rietveld refinements of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$ , and  $0.04$ ) compositions sintered at 1100°C. As exhibited in Figure 2A, each primitive unit cell consists of eight  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  formula units.  $\text{Nb}^{5+}$  cations occupy one set of octahedral sites, while Li/Mg cations randomly occupy the other three octahedral sites. Li/Nb/Mg cations are linked to six oxygen atoms to form an oxygen octahedron.<sup>35</sup> Adopting  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  as the initial model, Rietveld refinements were conducted using the EXPGUI software for all the compositions. Figure 2A-F present the refinement patterns of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$ , and  $0.04$ ) compositions sintered at 1100°C. The results showed that the calculated patterns are consistent with the measured data and the  $R_p$  values are less than 6%, whereas the  $R_{wp}$  values are less than 7%, indicating that the structural models for Rietveld refinements are reliable. The structural parameters of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ceramics for Rietveld refinement are presented in Table S1. The Rietveld refinement parameters, including the reliability



**FIGURE 2** Crystal structure for  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  ceramics (A) and Rietveld refinement patterns for  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0-0.04$ ) ceramics, (B)  $x = 0$ , (C)  $x = 0.01$ , (D)  $x = 0.02$ , (E)  $x = 0.03$  and (F)  $x = 0.04$

factors ( $\chi^2$ ,  $R_{\text{wp}}$ , and  $R_p$ ), lattice constant and unit cell volume of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$ , and  $0.04$ ) ceramics are listed in Table 1.

### 3.2 | Structural analysis

It is well known that crystal structure plays a dominant role in determining microwave dielectric properties.<sup>4,36</sup> Therefore, it is essential to quantify Nb-O bonds and lattice vibrations in order to better understand the origins of microwave dielectric properties. These were investigated using Raman spectroscopy and Rietveld refinements. Due to the substitution of  $\text{Nb}^{5+}$  ions by  $\text{Ta}^{5+}$ , the crystal structure of  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  become slightly distorted, which may modify the microwave dielectric properties. The Nb-site bond valence and  $\text{NbO}_6$  octahedral distortions were calculated using Rietveld refinement. The  $\text{NbO}_6$  octahedral distortion was calculated using Equation 4.<sup>37</sup>

$$\delta = \frac{1}{6} \sum \left( \frac{R_i - \bar{R}}{\bar{R}} \right)^2 \quad (4)$$

where  $\bar{R}$  and  $R_i$  are the average and individual bond lengths of Nb-O bonds, respectively. The bond valence  $V_{ij}$  (atom  $i$ ) was determined using Equations 5 and 6.

$$V_{ij} = \sum v_{ij} \quad (5)$$

$$v_{ij} = \exp \left( \frac{R_{ij} - d_{ij}}{b} \right) \quad (6)$$

where  $R_{ij}$  represents the bond valence,  $b$  is a constant ( $0.37 \text{ \AA}$ ) and  $d_{ij}$  indicates the bond length between atoms  $i$  and  $j$ . The bond valence parameter  $R_{\text{NbO}}$  is  $1.911 \text{ \AA}$ .<sup>38</sup> The calculated results are listed in Table 2. The differences in  $\text{NbO}_6$  octahedral distortion and Nb-O bond valence are attributed to the lower electronegativity of  $\text{Ta}^{5+}$  ion compared with that of the  $\text{Nb}^{5+}$  ion. The  $\text{NbO}_6$  octahedral distortion and Nb-O bond valence were calculated to explore the dependence of  $\tau_f$  values on structural properties.



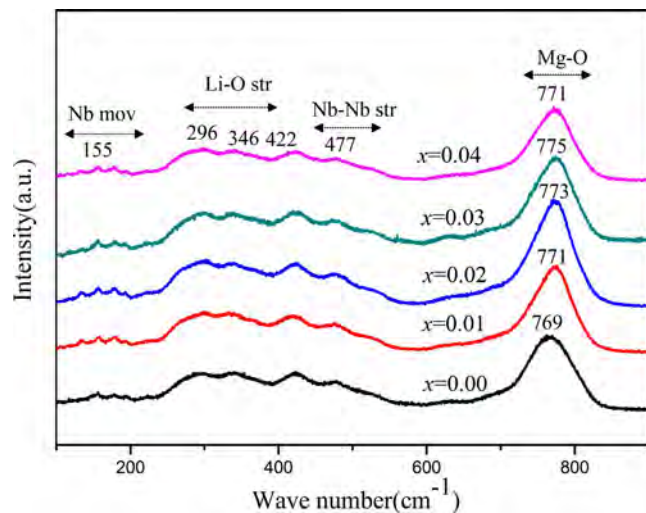
**TABLE 2** Bond lengths, Nb-site bond valence and distortion of NbO<sub>6</sub> octahedron of Li<sub>3</sub>Mg<sub>2</sub>Nb<sub>1-x</sub>Ta<sub>x</sub>O<sub>6</sub> ( $x = 0, 0.01, 0.02, 0.03$ , and  $0.04$ ) ceramics sintered at 1100°C

$x$	Bond	$d_{\text{Nb-O}}$	$\nu_{\text{Nb-O}}$	$V_{\text{Nb-O}}$	$\bar{R}$	$\delta$	$\tau_f$ (ppm/°C)
0.00	Nb-O(1) $\times$ 2	1.9579	0.8810	4.8324	1.9919	$1.46 \times 10^{-4}$	-17
	Nb-O(2) $\times$ 4	2.0089	0.7676				
0.01	Nb-O(1) $\times$ 2	1.9569	0.8833	4.8228	1.9927	$1.61 \times 10^{-4}$	-12.5
	Nb-O(2) $\times$ 4	2.0106	0.7640				
0.02	Nb-O(1) $\times$ 2	1.9585	0.8795	4.7805	1.9960	$1.77 \times 10^{-4}$	-4.5
	Nb-O(2) $\times$ 4	2.0148	0.7554				
0.03	Nb-O(1) $\times$ 2	1.9598	0.8764	4.7785	1.9959	$1.66 \times 10^{-4}$	-7.1
	Nb-O(2) $\times$ 4	2.0143	0.7564				
0.04	Nb-O(1) $\times$ 2	1.9574	0.8821	4.8153	1.9933	$1.62 \times 10^{-4}$	-14.3
	Nb-O(2) $\times$ 4	2.0112	0.7527				

Raman spectroscopy is extremely sensitive to local structure. In the present work, Raman spectroscopy is adopted to investigate modifications of crystal structure for Li<sub>3</sub>Mg<sub>2</sub>Nb<sub>1-x</sub>Ta<sub>x</sub>O<sub>6</sub> ceramics. According to the space group *Fddd* and symmetry analysis, the optical models are provided by the Bilbao Crystallographic Server<sup>39</sup> (see Equation 7).

$$\Gamma_{\text{Raman}} = 8A_g + 12B_{1g} + 15B_{2g} + 16B_{3g} \quad (7)$$

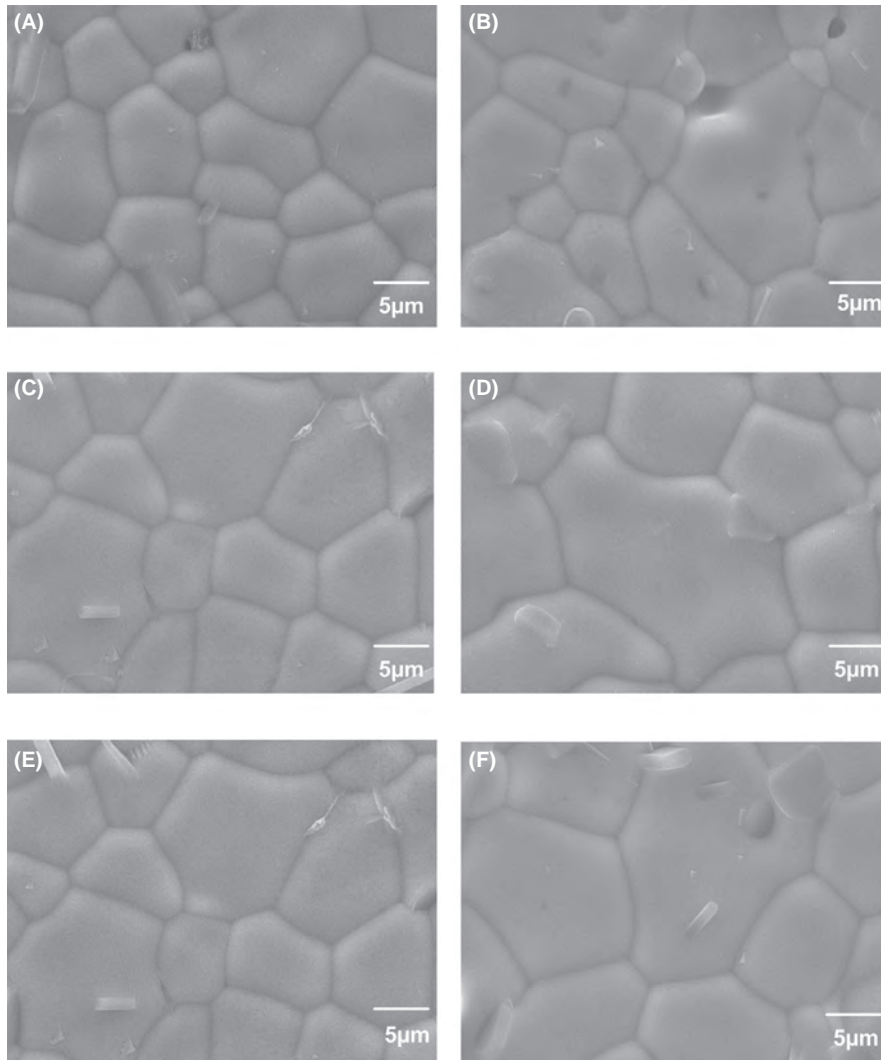
The factor group analysis exhibited that 51 Raman active vibrational modes exist in the Li<sub>3</sub>Mg<sub>2</sub>NbO<sub>6</sub> crystal structure. Due to the interaction or overlapping modes, the observed Raman spectra consisted of less vibrations than the theoretical model. As shown in Figure 3, all the compositions explored here possessed similar Raman spectra. The bands around 155 cm<sup>-1</sup> are correlated to Nb bond vibrations, while

**FIGURE 3** Raman spectra of the Li<sub>3</sub>Mg<sub>2</sub>Nb<sub>1-x</sub>Ta<sub>x</sub>O<sub>6</sub> ( $x = 0-0.04$ ) ceramic

the bands within the 250–450 cm<sup>-1</sup> were assigned to Li–O bond stretching vibrations according to studies of the Li<sub>2</sub>SiO<sub>3</sub> and Li<sub>(3-3x)</sub>M<sub>4x</sub>Nb<sub>(1-x)</sub>O<sub>4</sub> systems.<sup>21,40</sup> The band at around 477 cm<sup>-1</sup> may be attributed to Nb–Nb stretching, while the band at around 771 cm<sup>-1</sup> was assigned to Mg–O bond vibrations.<sup>41</sup> Notably, the band at 771 cm<sup>-1</sup> was at first shifted to a higher wavenumber, and then, to a lower wavenumber, which was highly correlated to the variation in unit cell volume.<sup>42</sup>

### 3.3 | Microstructure analysis

Figure 4 shows the SEM micrographs of Li<sub>3</sub>Mg<sub>2</sub>Nb<sub>1-x</sub>Ta<sub>x</sub>O<sub>6</sub> ( $x = 0, 0.01, 0.02, 0.03$ , and  $0.04$ ) samples. In the present work, the morphology, porosity and grain size were related to the compositions and dopant levels. The grain boundaries and dense microstructure were clearly observed for all sintered samples. As the content of Ta<sup>5+</sup> increased, the densification and average grain size first increased, and at higher doping levels, decreased. For  $x \leq 0.01$ , a porous microstructure was detected with an average grain size of around 9  $\mu\text{m}$ . For  $0.02 \leq x \leq 0.03$ , denser and more homogeneous microstructures were observed. Furthermore, the average grain size reached a maximum of about 12  $\mu\text{m}$ . For the sample with  $x = 0.04$ , the grain size decreased to 10.68  $\mu\text{m}$ . These results indicate that suitable levels of Ta<sup>5+</sup> substitutions promote grain growth and improve the density of Li<sub>3</sub>Mg<sub>2</sub>Nb<sub>1-x</sub>Ta<sub>x</sub>O<sub>6</sub> ceramics. In comparison, for  $x = 0.03$ , the sintered samples presented inhomogeneous microstructure with some relatively small grains. In comparison of SEM images, 1100°C was found to be the optimal sintering temperature. According to previous work, it is well known that grain boundaries contribute significantly to dielectric loss by acting as two-dimensional defects.<sup>43,44</sup> The increase in average grain size translates to a decrease in grain boundary density. Therefore, the grain size plays a key role in determining microwave



**FIGURE 4** Surface SEM micrographs of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ceramics sintered at 1100°C (A)  $x = 0$ , (B)  $x = 0.01$ , (C)  $x = 0.02$ , (D)  $x = 0.03$ , (E)  $x = 0.04$  and (F)  $x = 0.03$  sintered at 1125°C

dielectric properties. The distribution of grain size and average grain size of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ceramics sintered at 1100°C are shown in Figure S2. With the  $\text{Ta}^{5+}$  content reaching  $x = 0.03$ , the distribution of small grains vanishes and grain boundaries decreases, which improves  $Q \times f$  values. The measured average grain sizes were 9.36, 10.37, 10.71, 13.65, and 12.02  $\mu\text{m}$  for  $x = 0, 0.01, 0.02, 0.03$ , and 0.04, respectively. These results support that suitable  $\text{Ta}^{5+}$  substitution promotes grain growth.

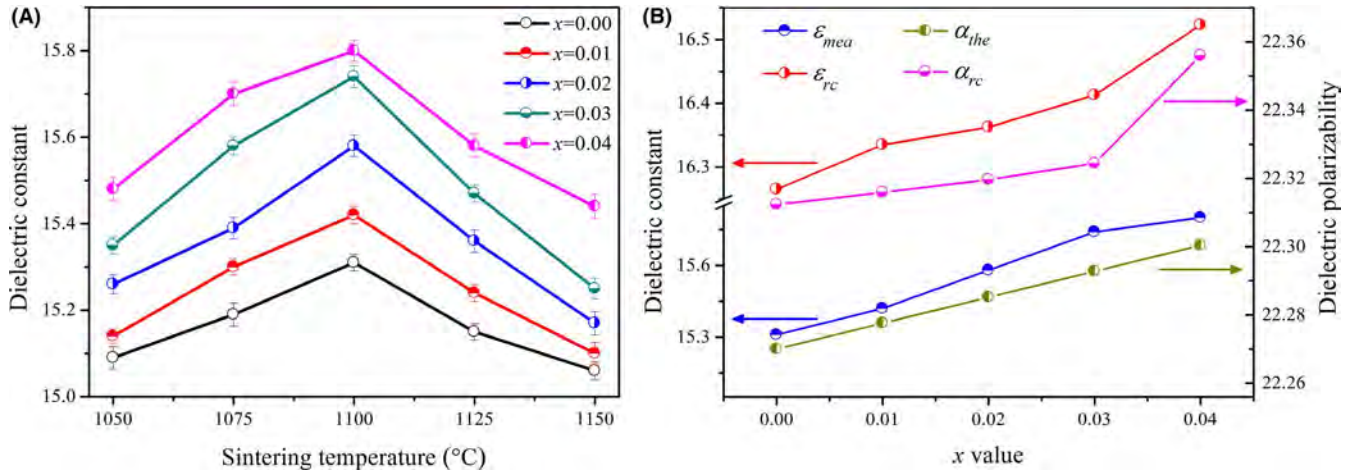
### 3.4 | Dielectric property analysis

Figure 5 presents the relative permittivity of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$ , and 0.04) ceramics for various sintering temperatures and  $\text{Ta}^{5+}$  substitution. Ordinarily, the relative permittivity is dependent on many factors, such as ionic polarizability, second phases and density.<sup>45</sup> In this study, the relative permittivity of all substitutional compositions increased (and then reduced) with the increase in sintering temperature, which was related to the relative

density and polarizability. Figures 1 and 2 show a single orthorhombic structure. Therefore, the effects of secondary phases on the dielectric constant is eliminated. The relationship among relative permittivity, relative density and polarizability can be described using the Clausius-Mosotti equation<sup>6</sup> (see Equation 8).

$$\frac{\epsilon_r - 1}{\epsilon_r + 2} = \frac{N\alpha}{3\epsilon_0} \quad (8)$$

where  $\alpha$ ,  $\epsilon_0$ , and  $\epsilon_r$  are the molecular polarizability, permittivity of the vacuum and dielectric ceramics, respectively. As the substituting  $\text{Ta}^{5+}$  content increased, the dielectric constant of as-sintered samples sintered at 1100°C increased, which can be attributed to higher ionic polarizability of  $\text{Ta}^{5+}$  (4.73 Å) than that of  $\text{Nb}^{5+}$  (3.97 Å). The theoretical dielectric polarizability ( $\alpha_{\text{theo}}$ ) of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ceramics was obtained using the Shannon's additive rule<sup>46</sup> (see Equation 9).



**FIGURE 5** Variation in dielectric constant of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ceramics with temperature (A), and dielectric constant of the ceramics sintered at 1100°C for various values of polarizability (B)

$$\alpha_{\text{theo}} = 3\alpha(\text{Li}^+) + 2\alpha(\text{Mg}^{2+}) + (1-x)\alpha(\text{Nb}^{5+}) + x\alpha(\text{Ta}^{5+}) + 6\alpha(\text{O}^{2-}) \quad (9)$$

where  $\alpha(\text{Ta}^{5+}) = 4.37 \text{ \AA}^3$ ,  $\alpha(\text{Nb}^{5+}) = 3.97 \text{ \AA}^3$ ,  $\alpha(\text{Mg}^{2+}) = 1.32 \text{ \AA}^3$ ,  $\alpha(\text{O}^{2-}) = 2.01 \text{ \AA}^3$  and  $\alpha(\text{Li}^+) = 1.20 \text{ \AA}^3$  are the ionic polarizabilities. In order to eliminate the impact of porosity on permittivity, permittivity was corrected using Equation 10.<sup>47</sup>

$$\epsilon_{\text{mea}} = \epsilon_{\text{rc}} \left( 1 - \frac{3p(\epsilon_{\text{rc}} - 1)}{2\epsilon_{\text{rc}} + 1} \right) \quad (10)$$

where  $p$ ,  $\epsilon_{\text{mea}}$ , and  $\epsilon_{\text{rc}}$  are the porosity fraction, measured permittivity and porosity-corrected permittivity, respectively. In order to determine the porosity fraction, the theoretical density, calculated based on the results of refinement, was determined to be approximately  $3.84 \text{ g/cm}^3$ . The observed dielectric polarizability ( $\alpha_{\text{obs}}$ ) was obtained using the abovementioned porosity-corrected permittivity<sup>48,49</sup> (see Equation 11).

$$\alpha_{\text{rc}} = \frac{V_m(\epsilon_{\text{rc}} - 1)}{b(\epsilon_{\text{rc}} + 2)} \quad (11)$$

where  $b$  and  $V_m$  are the constant ( $4\pi/3$ ) and the molar volume, respectively. Table 3 summarizes the results for  $\epsilon_{\text{mea}}$ ,  $\epsilon_{\text{rc}}$ ,  $\epsilon_{\text{theo}}$ ,  $\alpha_{\text{theo}}$ , and  $\alpha_{\text{obs}}$  of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ceramics sintered at 1100°C. As the substituting  $\text{Ta}^{5+}$  content increased, the porosity-corrected permittivity increased. The porosity-corrected dielectric polarizability increased with the increase in the substituting  $\text{Ta}^{5+}$  content, showing the same variation trend with theoretical dielectric polarizability. Based on Equations 9 and 11, the theoretical permittivity was calculated and presented in Table 3. Remarkably, an extremely small discrepancy of ( $\Delta =$

$(\alpha_{\text{theo}} - \alpha_{\text{rc}})/\alpha_{\text{rc}} \times 100\%$ )  $\leq 1\%$  existed among all the compositions, indicating that the calculated  $\alpha_{\text{obs}}$  values were in close agreement with  $\alpha_{\text{theo}}$  values. Additionally, a larger difference (5.1%) between the measured and theoretical permittivities was obtained. It is interesting that the porosity-corrected permittivity was larger than the theoretical permittivity, which is possibly related to polyhedral distortions and atomic vibrations, as reported in previous works.<sup>4,50</sup>

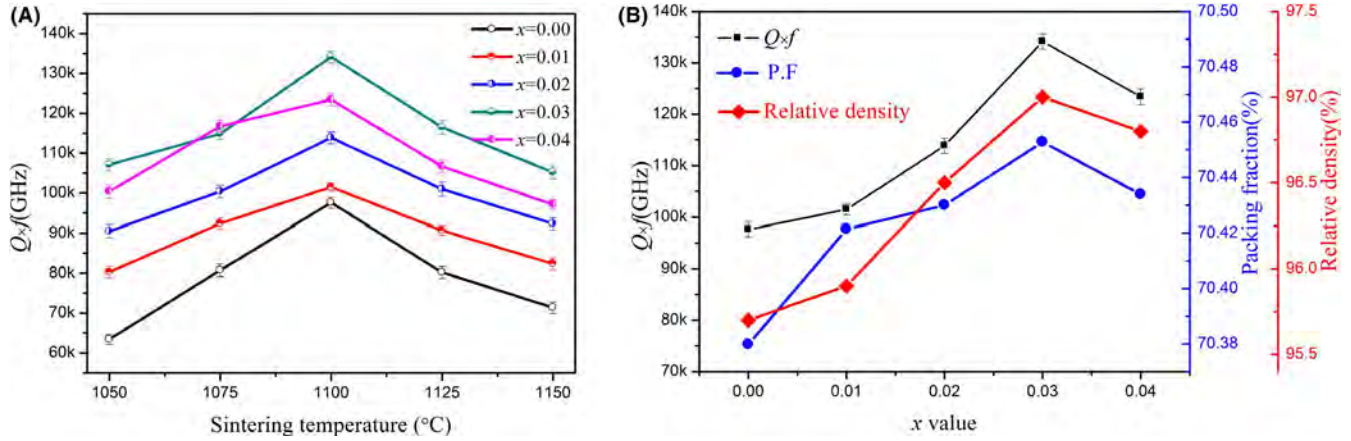
Figure 6 presents the  $Q \times f$  values of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$ , and  $0.04$ ) ceramics for different sintering temperatures and substituting  $\text{Ta}^{5+}$  contents. With the increase in sintering temperature, the  $Q \times f$  values first increased, and then, decreased for all compositions. It is well known that the  $Q \times f$  values are affected by many factors, including structural properties, grain size, secondary phases and density.<sup>4,36</sup> Therefore, the packing fraction was calculated to investigate its impact on  $Q \times f$  values<sup>50</sup> (see Equation 12).

$$\text{Packing fraction} = \frac{\text{volume of the atoms in the cell}}{\text{volume of unit cell}} \times Z \quad (12)$$

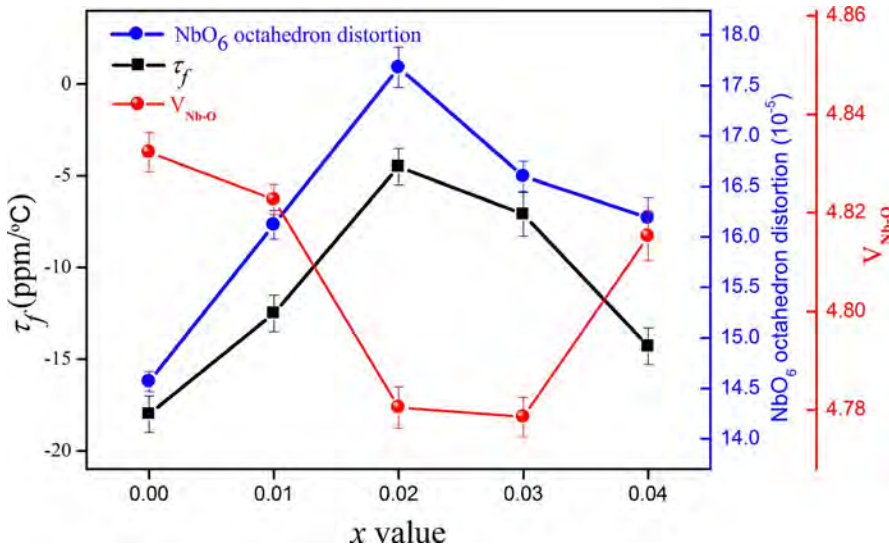
**TABLE 3** Measured dielectric constant ( $\epsilon_{\text{mea}}$ ), porosity-corrected dielectric constant ( $\epsilon_{\text{rc}}$ ), theoretical dielectric constants ( $\epsilon_{\text{theo}}$ ), observed dielectric polarizabilities ( $\alpha_{\text{obs}}$ ) and theoretical dielectric polarizabilities ( $\alpha_{\text{theo}}$ ) values of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$  and  $0.04$ ) ceramics sintered at 1100°C

$x$	0.00	0.01	0.02	0.03	0.04
$p$ (%)	4.3	4.1	3.5	3	3.2
$\epsilon_{\text{theo}}$	16.0903	16.1754	16.2184	16.2798	16.2865
$\epsilon_{\text{mea}}$	15.31	15.42	15.58	15.74	15.8
$\epsilon_{\text{rc}}$	16.2652	16.335	16.3626	16.4130	16.523
$\alpha_{\text{rc}}$	22.3124	22.3159	22.3197	22.3244	22.356
$\alpha_{\text{theo}}$	22.27	22.2776	22.2852	22.2928	22.3004
$\Delta$ (%)	0.19	0.173	0.154	0.142	0.249





**FIGURE 6**  $Q \times f$  values of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0\text{--}0.04$ ) ceramics at various temperatures (A), and  $Q \times f$  values of the sample sintered at 1100°C for various packing fractions (B)



**FIGURE 7**  $\tau_f$  values and  $\text{NbO}_6$  octahedron distortions for  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0\text{--}0.04$ ) ceramics sintered at 1100°C

where  $Z$  is 8 for  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  ceramics. The calculated results are listed in Table S2. Figure 6B presents the relationship among  $Q \times f$  values, packing fractions and relative densities. The  $Q \times f$  values increased, and then decreased, which is similar to trends in relative densities and packing fractions. However, the relative density was higher than 95%, indicating the density may be correlated but may not have a causal relationship with  $Q \times f$  values. Additionally, the trend in average grain size is similar to that of  $Q \times f$  values, as shown in Table S2. Therefore, it is implied that  $Q \times f$  values are dependent on the packing fraction and grain size.

Figure 7 exhibits  $\tau_f$  values and  $\text{NbO}_6$  octahedral distortion of  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$ , and  $0.04$ ) ceramics. Generally,  $\tau_f$  is correlated with the temperature coefficient of the dielectric constant ( $\tau_\epsilon$ ) following Equation 13.

$$\tau_f = -\alpha - \frac{1}{2}\tau_\epsilon \quad (13)$$

The  $\tau_\epsilon$  values are affected by structural properties including octahedral distortions and Nb-O bond valence. With the increase in the content of  $\text{Ta}^{5+}$ , the  $\tau_f$  values increased and then decreased, which is attributed to the  $\text{NbO}_6$  octahedral distortion and Nb-O bond valence.

## 4 | CONCLUSIONS

In the present work, low-loss  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0, 0.01, 0.02, 0.03$ , and  $0.04$ ) ceramics were fabricated using the solid-state reaction process. The impact of  $\text{Ta}^{5+}$  substitution on structural characteristic and the corresponding enhancement in the microwave dielectric properties were investigated. Based on Rietveld refinement results, all substituted compositions were indexed to a single orthorhombic  $\text{Li}_3\text{Mg}_2\text{NbO}_6$  phase. Additionally, homogeneous microstructures with uniform grain sizes ( $13.65 \mu\text{m}$ ) were observed for the  $\text{Li}_3\text{Mg}_2\text{Nb}_{1-x}\text{Ta}_x\text{O}_6$  ( $x = 0.03$ ) composition.  $\text{NbO}_6$



octahedral distortions, Nb-O bond valence, packing fraction and polarizability were measured and calculated to establish relationships between structural properties and microwave dielectric performance. Furthermore, an extremely small discrepancy between the values of  $\alpha_{\text{theo}}$  and  $\alpha_{\text{tc}}$  was observed and  $\epsilon_r$  values were correlated to polarizability. The  $Q \times f$  values were largely affected by the packing fraction and grain size. The  $\tau_f$  values depended on NbO<sub>6</sub> octahedral distortions and Nb-O bond valence. In particular, the Li<sub>3</sub>Mg<sub>2</sub>Nb<sub>1-x</sub>Ta<sub>x</sub>O<sub>6</sub> ( $x = 0.02$ ) composition exhibited substantial microwave dielectric enhancements:  $\epsilon_r = 15.58$ ,  $Q \times f = 113\,000$  GHz and  $\tau_f = -4.5$  ppm/°C, which provides a promising candidate for microwave and millimeter-wave applications.

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